Search Notes

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Applicant(s)/Patent under Reexamination

10/826,127

Examiner

FURUKAWA ET AL.

Art Unit

Brian E. Miller

2627

SEARCHED				
Class	Subclass	Date	Examiner	
360	324.1			
360	324.11			
360	324.12			
360	324.2	3/19/2006	ВЕМ	
updated	as above	8/29/2006	ВЕМ	
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INTERFERENCE SEARCHED				
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SEARCH N (INCLUDING SEARC)
	DATE	EXMR
reviewed parent application- 10/218247	3/19/2006	ВЕМ
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